

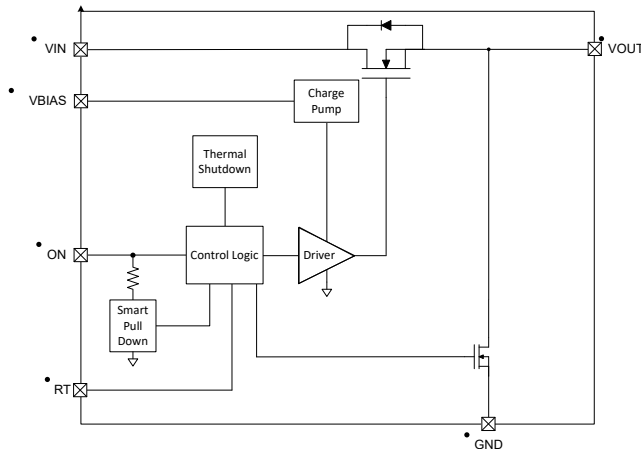
TPS22995H-Q1 5.5V、3A、19mΩ 导通电阻汽车类负载开关

1 特性

- 符合面向汽车应用的 AEC-Q100 标准：
 - 温度等级 1: - 40 °C 至 125 °C、T_A
- 输入电压范围 (V_{IN}): 0.8V 至 5.5V
- 偏置电压 (V_{BIAS}): 1.5V 至 5.5V
- 最大持续电流: 3A
- 导通电阻 (R_{ON}): 19mΩ (典型值)
- 通过外部电阻器实现可调压摆率控制
- 快速输出放电 (QOD): 100Ω (典型值)
- 热关断
- 耐湿引脚：
 - 100kΩ 接地短路
 - 100kΩ 电源短路
- ON 引脚智能下拉电阻 (R_{PD,ON}):
 - ON ≥ V_{IH} (I_{ON}): 25nA (最大值)
 - ON ≤ V_{IL} (R_{PD,ON}): 500kΩ (典型值)
- 低功耗：
 - 导通状态 (I_Q): 10μA (典型值)
 - 关闭状态 (I_{SD}): 0.1μA (典型值)

2 应用

- 信息娱乐系统
- 仪表组
- ADAS



方框图

3 说明

TPS22995H-Q1 是一款单通道负载开关，包含 19mΩ N 沟道 MOSFET，可在 0.8V 至 5.5V 的输入电压范围内运行，支持的连续电流上限为 3A。

该开关由可与低压 GPIO 信号直接连接的开关输入 (ON) 控制。TPS22995H-Q1 在开关关闭时具有快速输出放电功能，可将输出电压拉低至已知 0V 状态。此外，该器件还提供可调节上升功能，旨在限制具有高容性负载的浪涌电流。

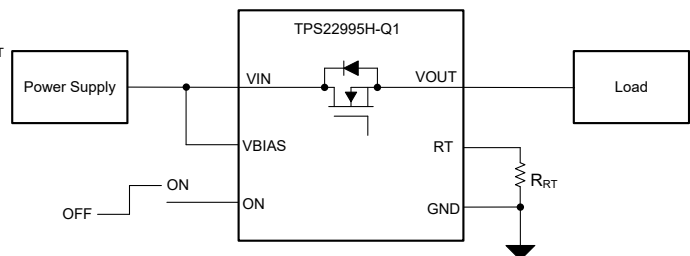
TPS22995H-Q1 的引脚可耐受高湿度条件，这意味着，无论哪个引脚与 GND 或电源之间发生 100kΩ 短路，该器件都能正常运行。时序引脚 (RT) 受高湿度影响时，预计时序保持在 +/-20% 范围内。

TPS22995H-Q1 采用 2.8mm × 2.9mm 6 引脚 SOT 封装，间距为 0.5mm。该器件在自然通风环境下的额定运行温度范围为 -40°C 至 +125°C。

封装信息

器件型号	封装 ⁽¹⁾	封装尺寸 (标称值)
TPS22995H-Q1	SOT-23 (DDC, 6)	2.80 mm × 2.90 mm

(1) 如需了解所有可用封装，请参阅数据表末尾的可订购产品附录。



典型应用图



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4 Revision History

注：以前版本的页码可能与当前版本的页码不同

Changes from Revision * (June 2022) to Revision A (December 2022)	Page
• 将器件状态从 <i>预告信息</i> 更改为 <i>量产数据</i>	1

5 Pin Configuration and Functions

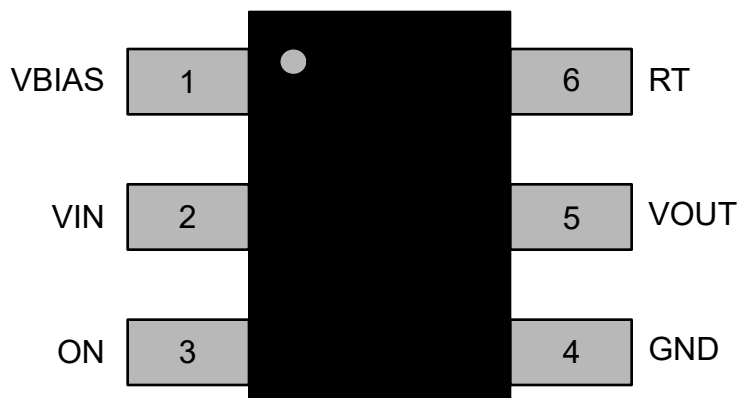


图 5-1. TPS22995H-Q1 DDC Package 6-Pin SOT-23 (Top View)

表 5-1. Pin Functions

PIN		TYPE ⁽¹⁾	DESCRIPTION
NAME	NO.		
VBIAS	1	P	Device bias supply
VIN	2	P	Switch input
ON	3	O	Enable pin to turn on/off the switch
GND	4	G	Device ground
VOUT	5	P	Switch output
RT	6	I	Slew rate control through a resistor to GND

(1) I = Input, O = Output, I/O = Input or Output, G = Ground, P = Power.

6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

		MIN	MAX	UNIT
V_{IN}	Input Voltage	- 0.3	6	V
V_{BIAS}	Bias Voltage	- 0.3	6	V
V_{ON}, V_{RT}	Control Pin Voltage	- 0.3	6	V
I_{MAX}	Maximum Current		3	A
T_J	Junction temperature		Internally Limited	°C
T_{stg}	Storage temperature	- 65	150	°C

- (1) Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.

6.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human-body model (HBM), per AEC Q100-002 ⁽¹⁾ HBM ESD classification level 1C	±2000	V
		Charged-device model (CDM), per AEC Q100-011 CDM ESD classification level C5	±1000	

- (1) AEC Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
V_{IN}	Input Voltage	0.8		5.5	V
V_{BIAS}	Bias Voltage	1.5		5.5	V
V_{IH}	ON Pin High Voltage Range	0.8		5.5	V
V_{IL}	ON Pin Low Voltage Range	0		0.35	V
T_A	Ambient Temperature	- 40		125	°C

6.4 Thermal Information

THERMAL METRIC ⁽¹⁾		TPS22995H-Q1	UNIT
		DDC	
		6 PINS	
R _{θ JA}	Junction-to-ambient thermal resistance	120.6	°C/W
R _{θ JC(top)}	Junction-to-case (top) thermal resistance	65.5	°C/W
R _{θ JB}	Junction-to-board thermal resistance	33.9	°C/W
Ψ _{JT}	Junction-to-top characterization parameter	17.2	°C/W
Υ _{JB}	Junction-to-board characterization parameter	3.6	°C/W

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

6.5 Electrical Characteristics (VBIAS = 5 V)

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T _A	MIN	TYP	MAX	UNIT
Power Consumption							
I _{SD,VBIAS}	VBIAS Shutdown Current	ON = 0V	25°C	0.1			µA
			- 40°C to 85°C	0.5			µA
			- 40°C to 125°C	2			µA
I _{Q,VBIAS}	VBIAS Quiescent Current	ON > V _{IH}	25°C	10			µA
			- 40°C to 85°C	20			µA
			- 40°C to 125°C	20			µA
I _{SD,VIN}	VIN Shutdown Current	ON = 0V	25°C	0.1			µA
			- 40°C to 85°C	1			µA
			- 40°C to 125°C	4			µA
I _{ON}	ON pin leakage	ON = VBIAS	- 40°C to 125°C	0.1			µA
Performance							
R _{ON}	On-Resistance	VIN = 5 V, I _{OUT} = -200 mA	25°C	19			m Ω
			- 40°C to 85°C	26			m Ω
			- 40°C to 125°C	29			m Ω
		VIN = 3.3 V, I _{OUT} = -200 mA	25°C	19			m Ω
			- 40°C to 85°C	25			m Ω
			- 40°C to 125°C	28			m Ω
		VIN = 1.8 V, I _{OUT} = -200 mA	25°C	19			m Ω
			- 40°C to 85°C	25			m Ω
			- 40°C to 125°C	28			m Ω
		VIN = 1.2 V, I _{OUT} = -200 mA	25°C	19			m Ω
			- 40°C to 85°C	25			m Ω
			- 40°C to 125°C	28			m Ω
		VIN = 0.8 V, I _{OUT} = -200 mA	25°C	19			m Ω
			- 40°C to 85°C	25			m Ω
			- 40°C to 125°C	28			m Ω
R _{PD,ON}	Smart Pull Down Resistance	ON < V _{IL}	25°C	500			k Ω
			- 40°C to 125°C	1000			k Ω
R _{QOD}	QOD Resistance	ON < V _{IL}	25°C	100			Ω
R _{QOD}			- 40°C to 125°C	150			Ω
Protection							
TSD	Thermal Shutdown		-	150	170	190	°C
TSD _{HYS}	Thermal Shutdown Hysteresis		-	20			°C

6.6 Electrical Characteristics (VBIAS = 3.3 V)

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T _A	MIN	TYP	MAX	UNIT
Power Consumption							
I _{SD,VBIAS}	VBIAS Shutdown Current	ON = 0 V	25°C		0.1		µA
			- 40°C to 85°C			0.5	µA
			- 40°C to 125°C			2	µA

6.6 Electrical Characteristics (VBIAS = 3.3 V) (continued)

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T _A	MIN	TYP	MAX	UNIT
I _{Q,VBIAS}	VBIAS Quiescent Current	ON > V _{IH}	25°C	8.5			μA
			- 40°C to 85°C	20			μA
			- 40°C to 125°C	20			μA
I _{SD,VIN}	VIN Shutdown Current	ON = 0V	25°C	0.1			μA
			- 40°C to 85°C	1			μA
			- 40°C to 125°C	4			μA
I _{ON}	ON pin leakage	ON = VBIAS	- 40°C to 125°C	0.1			μA
Performance							
R _{ON}	On-Resistance	VIN = 3.3 V, I _{OUT} = -200 mA	25°C	19			m Ω
			- 40°C to 85°C	26			m Ω
			- 40°C to 125°C	29			m Ω
		VIN = 1.8 V, I _{OUT} = -200 mA	25°C	19			m Ω
			- 40°C to 85°C	25			m Ω
			- 40°C to 125°C	28			m Ω
		VIN = 1.2 V, I _{OUT} = -200 mA	25°C	19			m Ω
			- 40°C to 85°C	25			m Ω
			- 40°C to 125°C	28			m Ω
		VIN = 0.8 V, I _{OUT} = -200 mA	25°C	19			m Ω
			- 40°C to 85°C	25			m Ω
			- 40°C to 125°C	28			m Ω
R _{PD,ON}	Smart Pull Down Resistance	ON < V _{IL}	25°C	500			k Ω
			- 40°C to 125°C	1000			k Ω
R _{QOD}	QOD Resistance	ON < V _{IL}	25°C	100			Ω
			- 40°C to 125°C	150			Ω
Protection							
TSD	Thermal Shutdown		-	150	170	190	°C
TSD _{HYS}	Thermal Shutdown Hysteresis		-	20			°C

6.7 Electrical Characteristics (VBIAS = 1.5 V)

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T _A	MIN	TYP	MAX	UNIT
Power Consumption							
I _{SD,VBIAS}	VBIAS Shutdown Current	ON = 0 V	25°C		0.1		μA
			– 40°C to 85°C			0.5	μA
			– 40°C to 125°C			2	μA
I _{Q,VBIAS}	VBIAS Quiescent Current	ON > V _{IH}	25°C		10		μA
			– 40°C to 85°C			20	μA
			– 40°C to 125°C			20	μA
I _{SD,VIN}	VIN Shutdown Current	ON = 0 V	25°C		0.1		μA
			– 40°C to 85°C			1	μA
			– 40°C to 125°C			4	μA
I _{ON}	ON pin leakage	ON = VBIAS	–40°C to 125°C		0.1		μA

6.7 Electrical Characteristics (VBIAS = 1.5 V) (continued)

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T _A	MIN	TYP	MAX	UNIT
Performance							
R _{ON}	On-Resistance	VIN = 1.5 V, I _{OUT} = -200 mA	25°C	22			m Ω
			- 40°C to 85°C	30			m Ω
			- 40°C to 125°C	34			m Ω
		VIN = 1.2 V, I _{OUT} = -200 mA	25°C	22			m Ω
			- 40°C to 85°C	30			m Ω
			- 40°C to 125°C	34			m Ω
		VIN = 0.8 V, I _{OUT} = -200 mA	25°C	21			m Ω
			- 40°C to 85°C	28			m Ω
			- 40°C to 125°C	31			m Ω
R _{PD,ON}	Smart Pull Down Resistance	ON < V _{IL}	25°C	500			k Ω
			- 40°C to 125°C	800			k Ω
R _{QOD}	QOD Resistance	ON < V _{IL}	25°C	100			Ω
			- 40°C to 125°C	150			Ω
Protection							
TSD	Thermal Shutdown		-	150	170	190	°C
TSD _{HYS}	Thermal Shutdown Hysteresis		-	20			°C

6.8 Switching Characteristics

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
VIN = 5.5 V						
t _{ON}	Turn ON time	R _L = 100 Ω, C _L = 10 uF, RT = 1 kΩ		264		us
t _{RISE}	Rise time	R _L = 100 Ω, C _L = 10 uF, RT = 1 kΩ		129		us
t _D	Delay time	R _L = 100 Ω, C _L = 10 uF, RT = 1 kΩ		127		us
t _{FALL}	Fall time	R _L = 100 Ω, C _L = 10 uF, RT = 1 kΩ		1100		us
t _{OFF}	Turn OFF time	R _L = 100 Ω, C _L = 10 uF, RT = 1 kΩ		60.2		us
VIN = 5 V						
t _{ON}	Turn ON time	R _L = 100 Ω, C _L = 10 uF, RT = 1 kΩ		294		us
t _{RISE}	Rise time	R _L = 100 Ω, C _L = 10 uF, RT = 1 kΩ		166		us
t _D	Delay time	R _L = 100 Ω, C _L = 10 uF, RT = 1 kΩ		127		us
t _{FALL}	Fall time	R _L = 100 Ω, C _L = 10 uF, RT = 1 kΩ		1110		us
t _{OFF}	Turn OFF time	R _L = 100 Ω, C _L = 10 uF, RT = 1 kΩ		60.3		us
VIN = 3.3 V						
t _{ON}	Turn ON time	R _L = 100 Ω, C _L = 10 uF, RT = 1 kΩ		259		us
t _{RISE}	Rise time	R _L = 100 Ω, C _L = 10 uF, RT = 1 kΩ		129		us
t _D	Delay time	R _L = 100 Ω, C _L = 10 uF, RT = 1 kΩ		130		us
t _{FALL}	Fall time	R _L = 100 Ω, C _L = 10 uF, RT = 1 kΩ		1120		us
t _{OFF}	Turn OFF time	R _L = 100 Ω, C _L = 10 uF, RT = 1 kΩ		62		us
VIN = 1.8 V						
t _{ON}	Turn ON time	R _L = 100 Ω, C _L = 10 uF, RT = 1 kΩ		224		us
t _{RISE}	Rise time	R _L = 100 Ω, C _L = 10 uF, RT = 1 kΩ		89.1		us

6.8 Switching Characteristics (continued)

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
tD	Delay time	$R_L = 100\ \Omega$, $C_L = 10\ \mu\text{F}$, $R_T = 1\ \text{k}\Omega$		135		us
tFALL	Fall time	$R_L = 100\ \Omega$, $C_L = 10\ \mu\text{F}$, $R_T = 1\ \text{k}\Omega$		1120		us
tOFF	Turn OFF time	$R_L = 100\ \Omega$, $C_L = 10\ \mu\text{F}$, $R_T = 1\ \text{k}\Omega$		65.2		us
VIN = 1.2 V						
tON	Turn ON time	$R_L = 100\ \Omega$, $C_L = 10\ \mu\text{F}$, $R_T = 1\ \text{k}\Omega$		208		us
tRISE	Rise time	$R_L = 100\ \Omega$, $C_L = 10\ \mu\text{F}$, $R_T = 1\ \text{k}\Omega$		68.6		us
tD	Delay time	$R_L = 100\ \Omega$, $C_L = 10\ \mu\text{F}$, $R_T = 1\ \text{k}\Omega$		140		us
tFALL	Fall time	$R_L = 100\ \Omega$, $C_L = 10\ \mu\text{F}$, $R_T = 1\ \text{k}\Omega$		1160		us
tOFF	Turn OFF time	$R_L = 100\ \Omega$, $C_L = 10\ \mu\text{F}$, $R_T = 1\ \text{k}\Omega$		66.7		us
VIN = 0.8 V						
tON	Turn ON time	$R_L = 100\ \Omega$, $C_L = 10\ \mu\text{F}$, $R_T = 1\ \text{k}\Omega$		197		us
tRISE	Rise time	$R_L = 100\ \Omega$, $C_L = 10\ \mu\text{F}$, $R_T = 1\ \text{k}\Omega$		53		us
tD	Delay time	$R_L = 100\ \Omega$, $C_L = 10\ \mu\text{F}$, $R_T = 1\ \text{k}\Omega$		144		us
tFALL	Fall time	$R_L = 100\ \Omega$, $C_L = 10\ \mu\text{F}$, $R_T = 1\ \text{k}\Omega$		1190		us
tOFF	Turn OFF time	$R_L = 100\ \Omega$, $C_L = 10\ \mu\text{F}$, $R_T = 1\ \text{k}\Omega$		69.5		us

6.9 Typical Characteristics

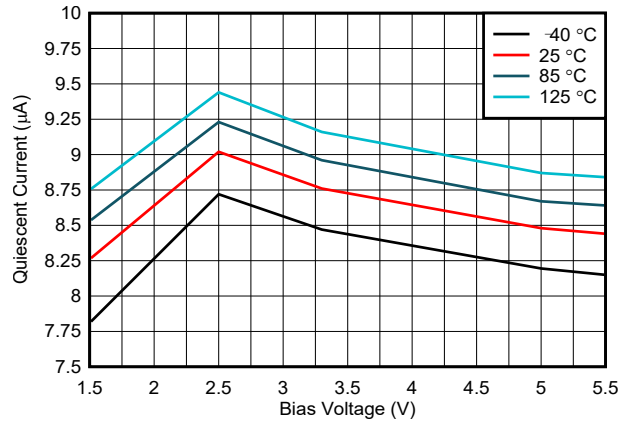


图 6-1. Quiescent Current vs Bias Voltage

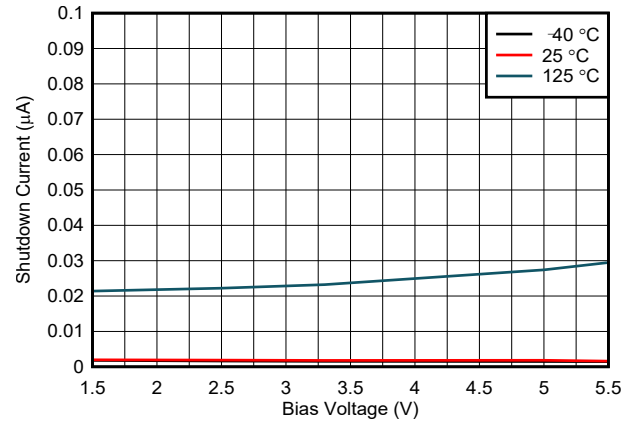


图 6-2. Shutdown Current vs Bias Voltage

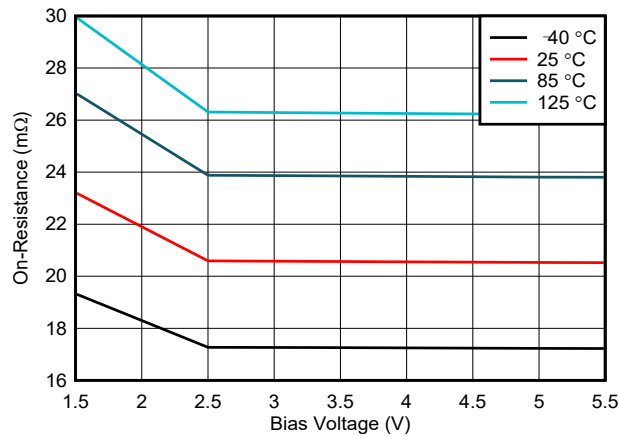


图 6-3. On-Resistance vs Bias Voltage

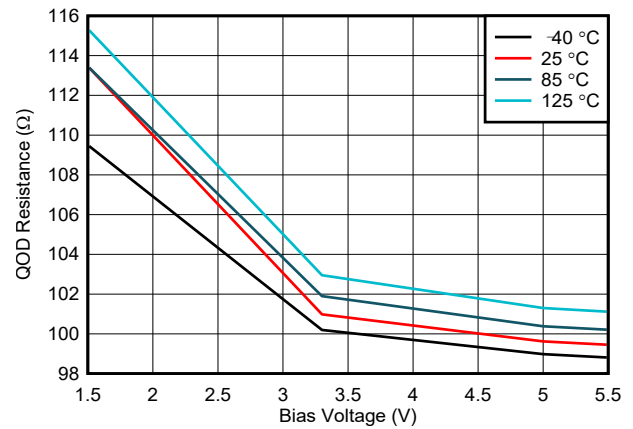


图 6-4. QOD Resistance vs Bias Voltage

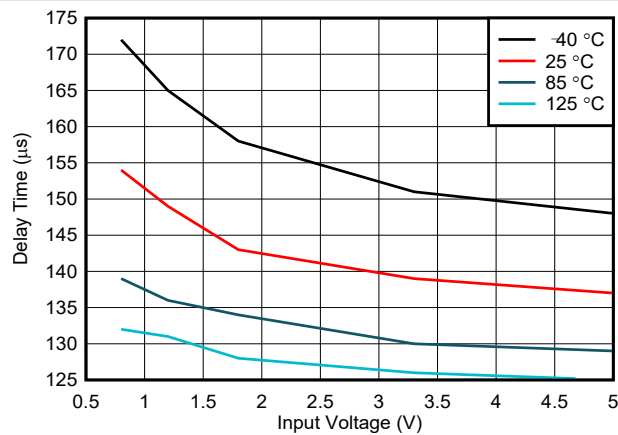


图 6-5. Delay Time vs Bias Voltage

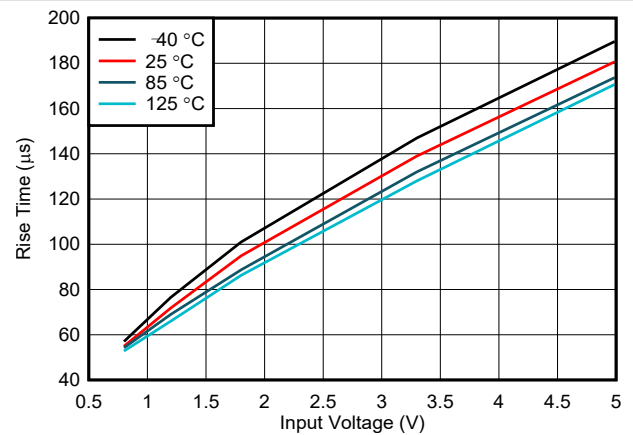


图 6-6. Rise Time vs Bias Voltage

7 Parameter Measurement Information

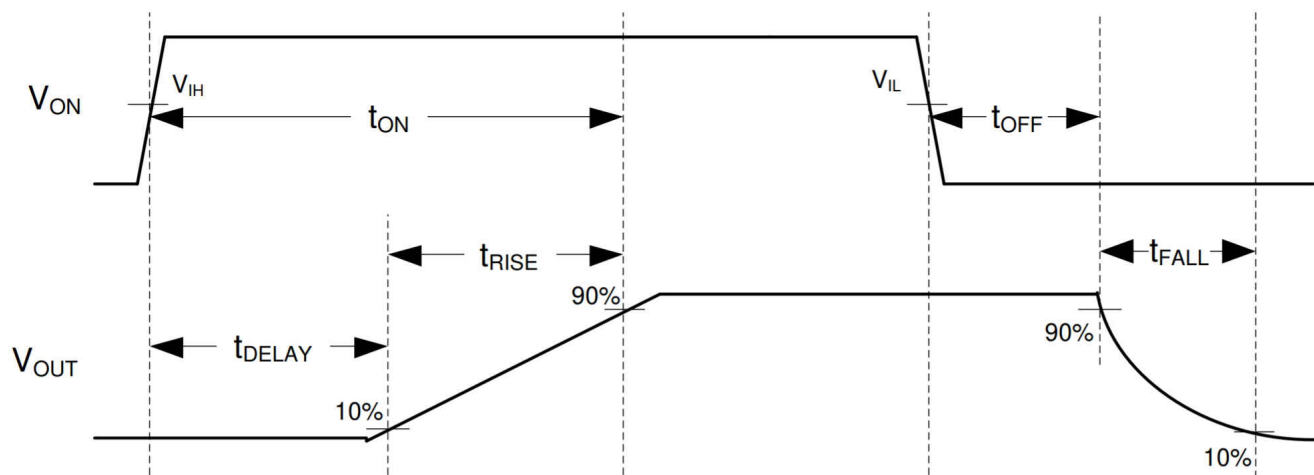


图 7-1. TPS22995H-Q1 Timing Parameters

8 Detailed Description

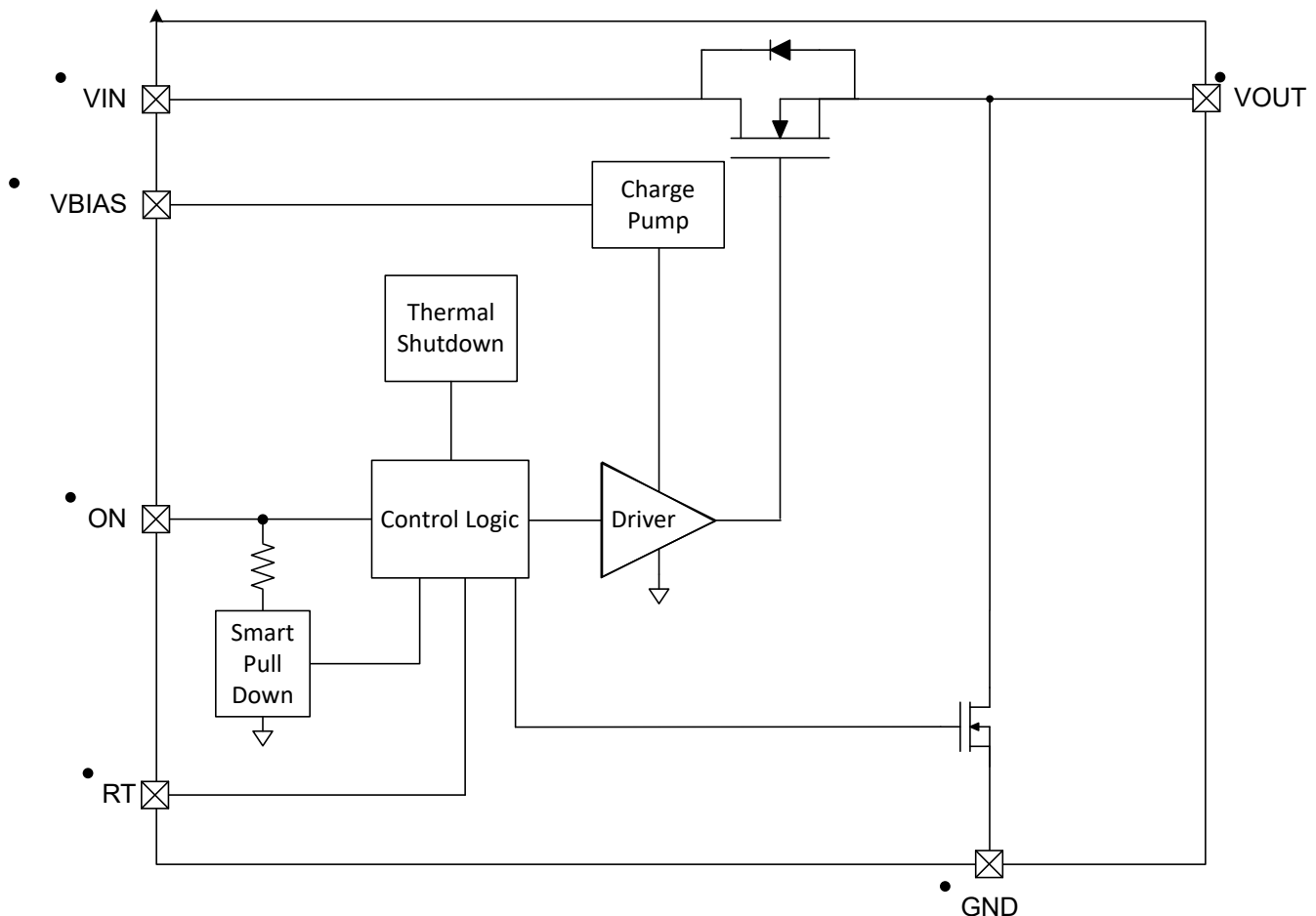
8.1 Overview

The TPS22995H-Q1 is a 5.5-V, 3-A load switch in a 6-pin SOT-23 package. To reduce voltage drop for low voltage and high-current rails, the device implements a low-resistance, 19-m Ω N-channel MOSFET, which reduces the drop-out voltage through the device.

The device has a configurable slew rate, which helps reduce or eliminate power supply droop because of large inrush currents. The slew rate can be configured by connecting a resistor to ground to the RT pin. The TPS22995H-Q1 also integrates a Quick Output Discharge circuit that is activated when the switch is turned off, pulling the output voltage down to a known 0-V state.

TPS22995H-Q1 increases circuit robustness by integrating tolerance to high humidity environments. When the timing pin (RT) is affected by high humidity, timing is expected to stay within $\pm 20\%$. Additionally, if the device experiences a 100-k Ω short from any pin to GND or power, the device continues to function.

8.2 Functional Block Diagram



8.3 Feature Description

8.3.1 ON and OFF Control

The ON pin controls the state of the switch. The ON pin is compatible with standard GPIO logic threshold so it can be used in a wide variety of applications. When power is first applied to VIN, a Smart Pulldown is used to keep the ON pin from floating until the system sequencing is complete. After the ON pin is deliberately driven high ($\geq V_{IH}$), the Smart Pulldown is disconnected to prevent unnecessary power loss. See the below table when the ON Pin Smart Pulldown is active.

表 8-1. On Pin Control

ON Pin Voltage	ON Pin Function
$\leq V_{IL}$	Pulldown active
$\geq V_{IH}$	No Pulldown

8.3.2 Quick Output Discharge (QOD)

TPS22995H-Q1 integrates Quick Output Discharge. When the switch is disabled, a discharge resistor is connected between VOUT and GND. This resistor has a typical value of 100 Ω and prevents the output from floating while the switch is disabled

8.3.3 Adjustable Slew Rate

A resistor to GND on the RT pin sets the slew rate, and the higher the resistor the lower the slew rate. Rise times are shown below.

表 8-2. Rise Time vs RT vs V_{IN}

RT Resistor	$V_{IN} = 5\text{ V}$	$V_{IN} = 3.3\text{ V}$	$V_{IN} = 1.8\text{ V}$	$V_{IN} = 1.2\text{ V}$	$V_{IN} = 0.8\text{ V}$
GND	102 μs	79 μs	55 μs	42 μs	33 μs
1 k Ω	166 μs	129 μs	89 μs	68 μs	53 μs
5 k Ω	790 μs	607 μs	415 μs	318 μs	242 μs
10 k Ω	1520 μs	1180 μs	800 μs	613 μs	465 μs
Open	4860 μs	3750 μs	2560 μs	1960 μs	1490 μs

The following equation can be used to estimate the rise time for different V_{IN} and RT resistors:

$$t_R = (0.0246 V_{IN} + 0.0308) \times RT + 3.3219 V_{IN} + 6.7312$$

where

- t_R = Rise time in μs .
- V_{IN} = Input voltage in V.
- RT = RT Resistor in Ω .

8.3.4 Thermal Shutdown

When the device temperature reaches 170°C (typical), the device shuts itself off to prevent thermal damage. After the device cools off by about 20°C, it turns back on. If the device is kept in a thermally stressful environment, then the device oscillates between these two states until it can keep its temperature below the thermal shutdown point.

8.4 Device Functional Modes

表 8-3. Device Functional Modes

ON	Fault Condition	VOUT State
L	N/A	Hi-Z
H	None	V_{IN} through R_{ON}
X	Thermal shutdown	Hi-Z

9 Application and Implementation

备注

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

9.1 Application Information

The input to output voltage drop in the device is determined by the R_{ON} of the device and the load current. The R_{ON} of the device depends upon the V_{IN} and V_{BIAS} condition of the device. See the R_{ON} specification in the [Electrical Characteristics \(\$V_{BIAS} = 5\text{ V}\$ \)](#) table of this data sheet. After the R_{ON} of the device is determined based upon the V_{IN} and V_{BIAS} conditions, use the below equation to calculate the input to output voltage drop.

$$\Delta V = I_{LOAD} \times R_{ON} \quad (1)$$

where

- ΔV is the voltage drop from V_{IN} to V_{OUT} .
- I_{LOAD} is the load current.
- R_{ON} is the on-resistance of the device for a specific V_{IN} and V_{BIAS} .
- An appropriate I_{LOAD} must be chosen such that the I_{MAX} specification of the device is not violated.

9.2 Typical Application

This typical application demonstrates how the TPS22995H-Q1 device can be used to limit start-up inrush current.

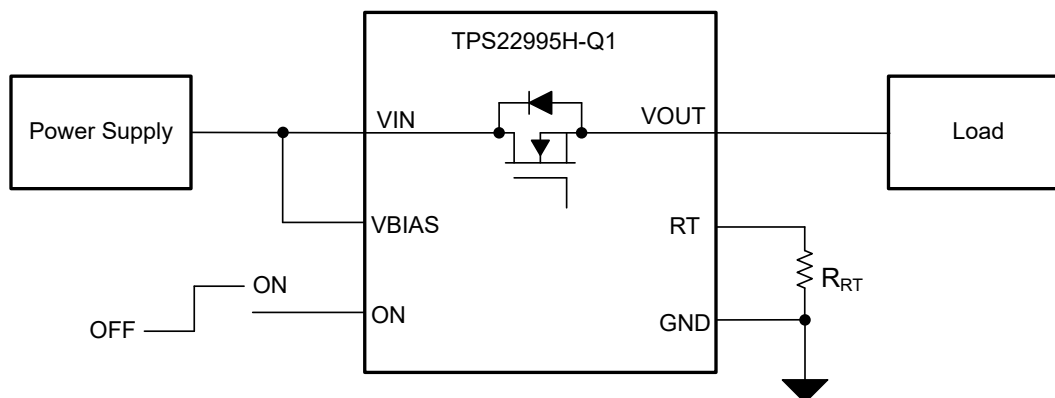


图 9-1. TPS22995H-Q1 Application Schematic

9.2.1 Design Requirements

表 9-1. Design Parameters

DESIGN PARAMETER	EXAMPLE VALUE
V_{BIAS}	5.0 V
V_{IN}	5.0 V
C_L	47 μF
R_L	None
Maximum acceptable inrush current	200 mA

9.2.2 Detailed Design Procedure

When the switch is enabled, the output capacitors must be charged up from 0 V to V_{IN} . This charge arrives in the form of inrush current. Use the equation below to calculate inrush current.

$$I_{INRUSH} = C_L \times dV_{OUT}/dt \quad (2)$$

where

- C_L is the output capacitance.
- dV_{OUT} is the change in V_{OUT} during the ramp up of the output voltage when device is enabled.
- dt is the rise time in V_{OUT} during the ramp up of the output voltage when the device is enabled.

The TPS22995H-Q1 offers an adjustable rise time for V_{OUT} , allowing the user to control the inrush current during turn-on. The appropriate rise time can be calculated using the design requirements and the inrush current equation as shown below.

$$200 \text{ mA} = 47\mu\text{F} \times 5 \text{ V}/dt \quad (3)$$

where

$$dt = 1175 \text{ us} \quad (4)$$

The TPS22995H-Q1 has very fast rise times with RT pin grounded. The typical rise time is $147 \mu\text{s}$ at $V_{BIAS} = 5\text{V}$, $V_{IN} = 5\text{V}$, $R_L = 100 \Omega$, and $C_L = 0.1 \mu\text{F}$. This rise time results in an inrush current of 1.59 A. According to the rise time [table](#), using $R_T = 10 \text{ k}\Omega$ results in a rise time of 1520 us, which limits the inrush current to 154 mA. Alternatively, the [rise time equation](#) can be used to determine the resistor need.

9.3 Power Supply Recommendations

The TPS22995H-Q1 device is designed to operate with a V_{IN} range of 0.8 V to 5.5 V. The V_{IN} power supply must be well regulated and placed as close to the device terminal as possible. The power supply must be able to withstand all transient load current steps. In most situations, using an input capacitance (C_{IN}) of $1 \mu\text{F}$ is sufficient to prevent the supply voltage from dipping when the switch is turned on. In cases where the power supply is slow to respond to a large transient current or large load current step, additional bulk capacitance can be required on the input.

9.4 Layout

9.4.1 Layout Guidelines

For best performance, all traces must be as short as possible. To be most effective, the input and output capacitors must be placed close to the device to minimize the effects that parasitic trace inductances can have on normal operation. Using wide traces for V_{IN} , V_{OUT} , and GND helps minimize the parasitic electrical effects.

9.4.2 Layout Example

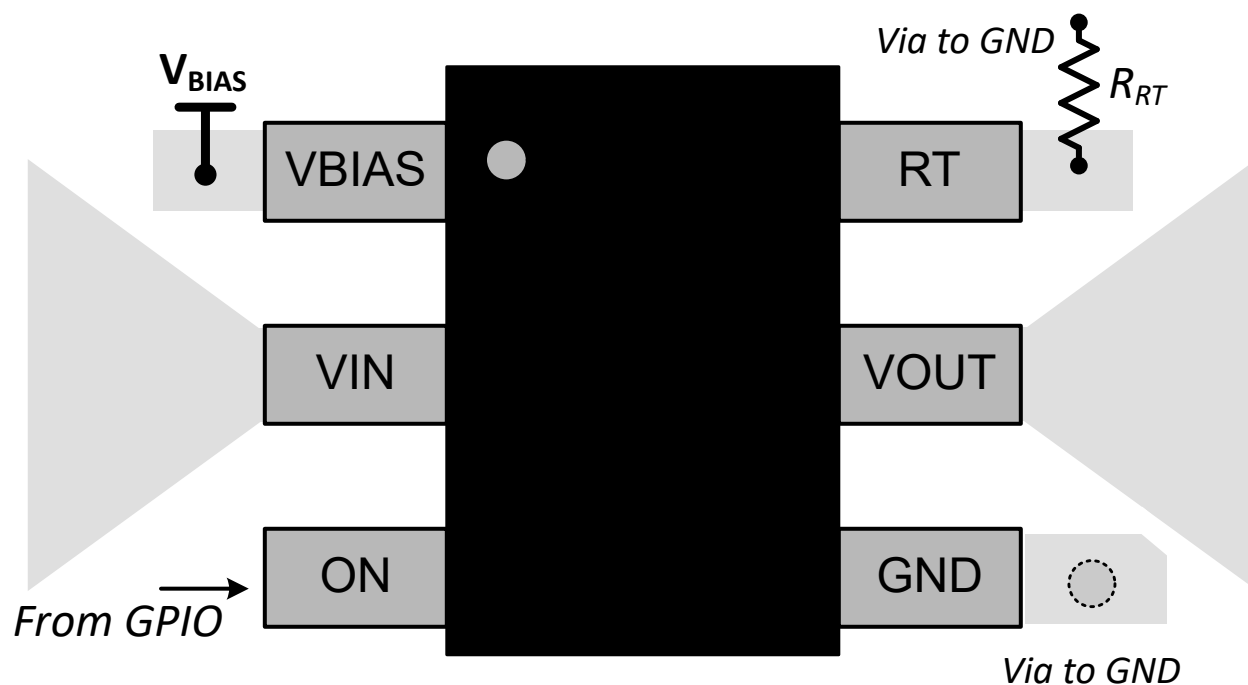


图 9-2. Layout Example (SOT)

10 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

10.1 接收文档更新通知

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10.2 支持资源

TI E2E™ 支持论坛是工程师的重要参考资料，可直接从专家获得快速、经过验证的解答和设计帮助。搜索现有解答或提出自己的问题可获得所需的快速设计帮助。

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10.3 Trademarks

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10.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

10.5 术语表

TI 术语表 本术语表列出并解释了术语、首字母缩略词和定义。

11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TPS22995HQDDCRQ1	ACTIVE	SOT-23-THIN	DDC	6	3000	RoHS & Green	Call TI	Level-1-260C-UNLIM	-40 to 125	995H	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBsolete: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

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(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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